

## United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/629,015	07/29/2003	Kimberly Kuhlman	CIT.PAU.39	7638
23386 759	90 11/01/2005		EXAM	INER
MYERS DAWES ANDRAS & SHERMAN, LLP			NGUYEN, KIET TUAN	
19900 MACAR'	THUR BLVD.,			
SUITE 1150	·		ART UNIT	PAPER NUMBER
IRVINE, CA 9	92612		2881	

DATE MAILED: 11/01/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

·			09-
	Application No.	Applicant(s)	H
	10/629,015	KUHLMAN ET AL.	
Office Action Summary	Examiner	Art Unit	
	Kiet T. Nguyen	2881	
The MAILING DATE of this communication Period for Reply	appears on the cover sheet w	ith the correspondence address	
A SHORTENED STATUTORY PERIOD FOR RE WHICHEVER IS LONGER, FROM THE MAILING  - Extensions of time may be available under the provisions of 37 CF after SIX (6) MONTHS from the mailing date of this communication  - If NO period for reply is specified above, the maximum statutory pe  - Failure to reply within the set or extended period for reply will, by st Any reply received by the Office later than three months after the nearned patent term adjustment. See 37 CFR 1.704(b).	G DATE OF THIS COMMUNI: R 1.136(a). In no event, however, may a land. Briod will apply and will expire SIX (6) MON tatute, cause the application to become Al	CATION. reply be timely filed NTHS from the mailing date of this communicati BANDONED (35 U.S.C. § 133).	
Status			
1) Responsive to communication(s) filed on 1	9 May 2005.		
2a)⊠ This action is <b>FINAL</b> . 2b)□	This action is non-final.		
3) Since this application is in condition for all			is
closed in accordance with the practice und	er <i>Ex parte Quayle</i> , 1935 C.E	). 11, 453 O.G. 213.	
Disposition of Claims			
4) Claim(s) 1-6,8-11,13-27,29,30,32-37,39,41	and 42 is/are pending in the	application.	
4a) Of the above claim(s) is/are with	drawn from consideration.		
5) Claim(s) <u>1-6,8-11,13-18,29,30,32-36,41 ar</u>	nd 42 is/are allowed.		
6)⊠ Claim(s) <u>19-26,37 and 39</u> is/are rejected.			
7) Claim(s) <u>27</u> is/are objected to.			
8) Claim(s) are subject to restriction ar	nd/or election requirement.		
Application Papers			
9)☐ The specification is objected to by the Exar	niner.		
10) ☐ The drawing(s) filed on is/are: a) ☐	• •	•	
Applicant may not request that any objection to	= · · ·		
Replacement drawing sheet(s) including the co			
Priority under 35 U.S.C. § 119			
12) ☐ Acknowledgment is made of a claim for fore a) ☐ All b) ☐ Some * c) ☐ None of:		§ 119(a)-(d) or (f).	
1. Certified copies of the priority docum			
2. Certified copies of the priority docum			
3. Copies of the certified copies of the	*	received in this National Stage	
application from the International Bu * See the attached detailed Office action for a	, , , , , , , , , , , , , , , , , , , ,	received	
dee the attached detailed office detail for a	That of the defined dopled het	Tooliveu.	
Attachment(s)			
<ol> <li>Notice of References Cited (PTO-892)</li> <li>Notice of Draftsperson's Patent Drawing Review (PTO-948)</li> </ol>	·	Summary (PTO-413) s)/Mail Date	
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SE Paper No(s)/Mail Date	′	Informal Patent Application (PTO-152)	

The amendment filed on 19 May 2005 has been acknowledged.

The final rejection, applied to claims 1-6, 8-11, 13-18, 25-27, 29-30, 32-37, 39 and 41-42 under 35 U.S.C. 112 first paragraph, applied to claims 1-4, 8, 11, 14-18, 29 and 33 under 35 U.S.C. 102(b) anticipated by Larson et al. ("Advances in Atom Probe Specimen Fabrication from Planar Multilayer Thin Film Structures"), and applied to claims 5-6, 9-10, 13, 27, 30, 32, 34-36 and 41-42 under 35 U.S.C. 103(a) unpatentable over Larson et al. ("Advances in Atom Probe Specimen Fabrication from Planar Multilayer Thin Film Structures"), is now withdrawn because applicant's remarks rebutting this rejection has been found to be persuasive; in that the term "nonlithographically" is defined as mechanical, electrical or chemical means (see page 4, lines 12-16 or [0014] of the specification). However, the final rejection applied to claims 19-26, 37 and 39 is still maintained because each of the independent claims 19, 25, 37 and 39 does not recite any means that is distinction from Larson et al. ("Advances in Atom Probe Specimen Fabrication from Planar Multilayer Thin Film Structures").

## Rejection Under 35 U.S.C. 102(b)

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

<sup>(</sup>b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 19-26, 37 and 39 are rejected under 35 U.S.C. 102(b) as being anticipated by Larson et al. ("Advances in Atom Probe Specimen Fabrication from Planar Multilayer Thin Film Structures").

Larson et al. disclose, in figs. 1-10, a method for preparation of a specimen for atom probe analysis. The method includes lithographically defining a plurality of posts having prismatic and quadrilateral sections in a slab (see at least some posts having the same dimensions arranged in col. of fig. 2), having a very high aspect ratio (see page 26, lines 8-11 in left col.), defined by parallel and intersecting cutting grooves (see fig. 2); removing the posts from the slab (see fig. 3); mounting the post on a metallic pin (see fig. 4); using FIB for shaping the post to a tip shape (see fig. 5); filling an oxide film to serve as an etch stop for lithographic patterning of the posts (see page 26, lines 1-10 in left col.); and fracturing the posts from the slab by a knife or other sharp implement (see page 26, lines 7-11 in right col.).

Claims 1-6, 8-11, 13-18, 29-30, 32-36 and 41-42 are allowed.

Claim 27 is objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

## Reasons for indicating allowable subject matter

The prior art fails to disclose a method and/or source for producing a multiplicity of individual specimens for atom probe analysis, which includes means for nonlithographically defining a plurality of removable high aspect ration posts in a slab as

Application/Control Number: 10/629,015

Art Unit: 2881

recited in claims 1 and 29; or means for cross sawing grooves into a slab of material for defining a plurality of high aspect ratio posts as recited in claims 27, 41 and 42.

Applicant's arguments filed on 19 May 2005 have been fully considered but they are not persuasive in view of the foregoing reasons.

## **REMARKS**

Applicant is requested to address all features in each claim in the rejection above. Since, at least some the features in at least some independent claims 19, 25, 37 and 39 are not mentioned in previous responses.

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Kiet T. Nguyen whose telephone number is 571-272-2479. The examiner can normally be reached on Monday-Friday from 8.00 AM to 6.00 PM.

Application/Control Number: 10/629,015 Page 5

Art Unit: 2881

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John R Lee, can be reached on Monday-Friday. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

KIET T. NGUYEN PRIMARY EXAMINER